

**• General Description**

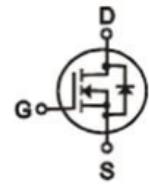
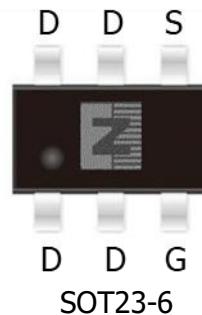
It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

• Product Summary $V_{DS} = 100V$ $R_{DS(ON)} = 90m\Omega$ $I_D = 3.5A$ **• Ordering Information:**

Part NO.	ZMS900N10U
Marking	900N10
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_C = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_C = 25^\circ C$	3.5	A
	$I_D @ T_C = 75^\circ C$	2.6	A
	$I_D @ T_C = 100^\circ C$	2.2	A
Pulsed Drain Current ⁽¹⁾	I_{DM}	10.5	A
Total Power Dissipation($T_C = 25^\circ C$)	$P_D @ T_C = 25^\circ C$	2	W
Total Power Dissipation($T_A = 25^\circ C$)	$P_D @ T_A = 25^\circ C$	1.3	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ C$
Storage Temperature	T_{STG}	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	5	mJ


•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}	-	-	60	° C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	100	° C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	265	° C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	100			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.3	1.8	2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =100V, V _{GS} =0V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V ,V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =3.5A		90	100	mΩ
		V _{GS} =4.5V, I _D =2A		95	105	mΩ
Forward Transconductance	g _{FS}	V _{DS} =10V, I _D =2A		2		s
Diode Forward Voltage	V _{FSD}	I _S =3.5A			1.28	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V f = 1MHz	-	266	-	pF
Output capacitance	C _{oss}		-	138	-	
Reverse transfer capacitance	C _{rss}		-	25	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DD} =25V I _D = 2A V _{GS} = 10V	-	4.7	-	nC
Gate - Source charge	Q _{gs}		-	1.2	-	
Gate - Drain charge	Q _{gd}		-	0.64	-	

Note: ① Pulse Test : Pulse width ≤ 10μs, Duty cycle ≤ 1% ;



Fig.1 Power Dissipation Derating Curve

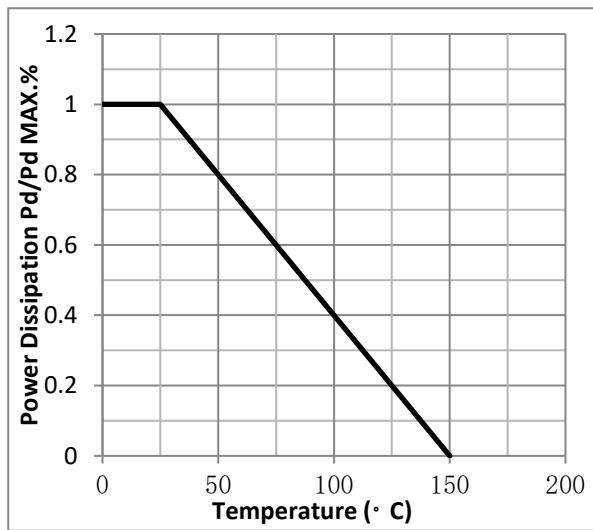


Fig.2 Typical output Characteristics

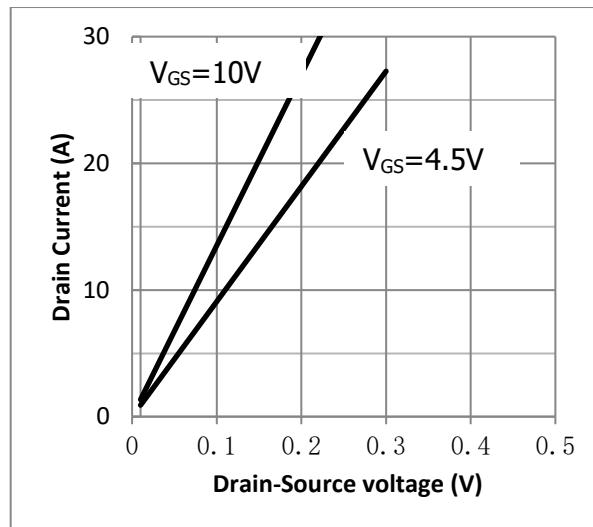


Fig.3 Threshold Voltage V.S Junction Temperature

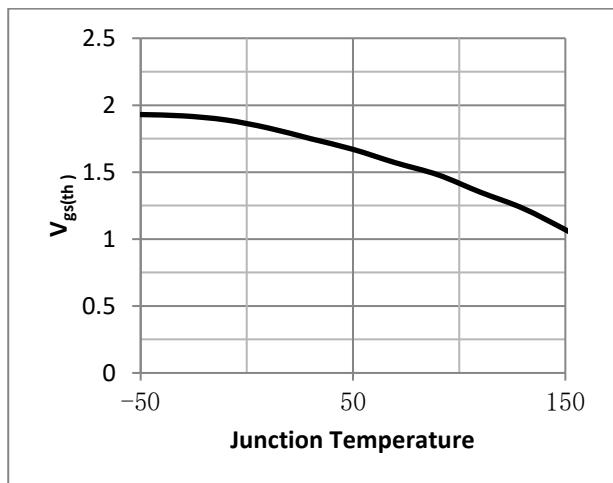


Fig.4 Resistance V.S Drain Current

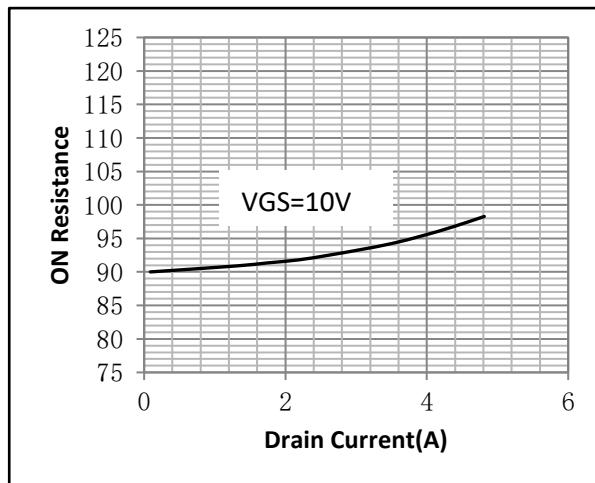


Fig.5 On-Resistance VS Gate Source Voltage

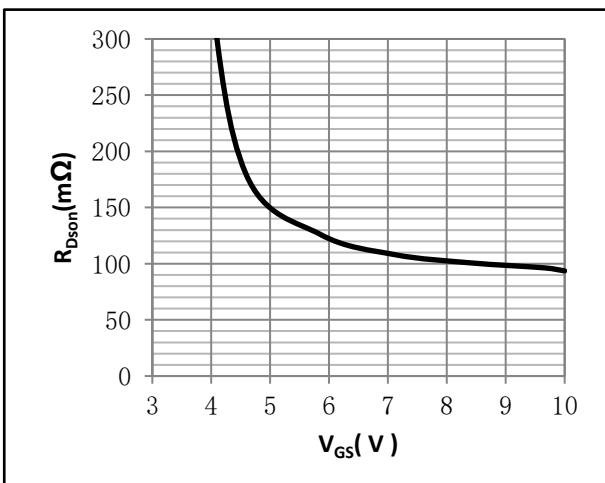


Fig.6 On-Resistance V.S Junction Temperature

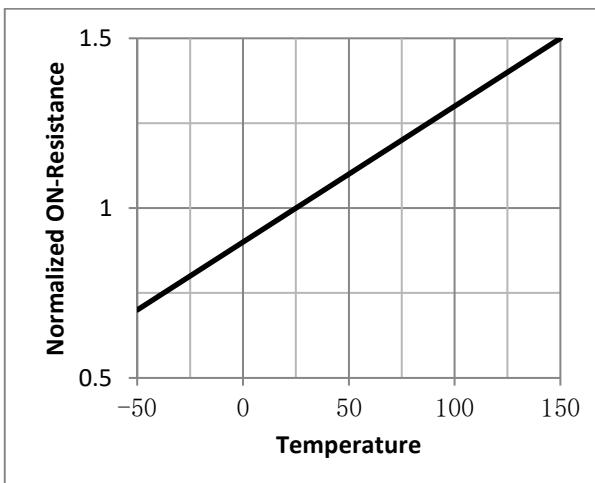




Fig.7 Gate Charge Measurement Circuit

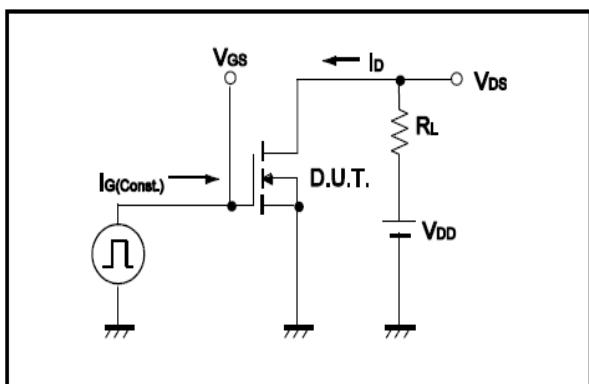


Fig.8 Gate Charge Waveform

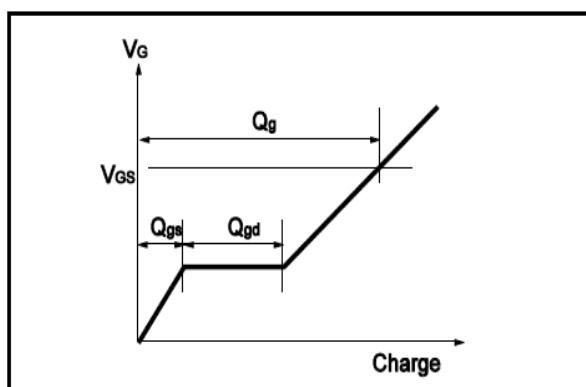


Fig.9 Switching Time Measurement Circuit

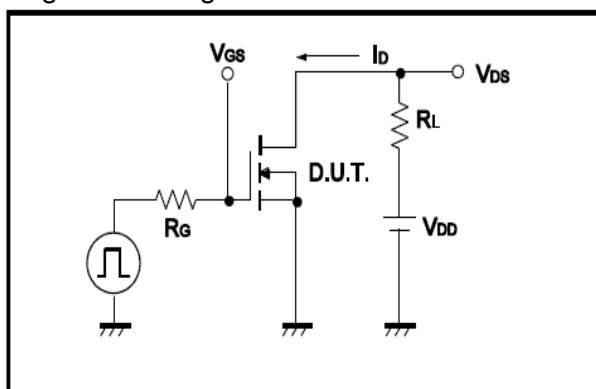


Fig.10 Switching Time Waveform

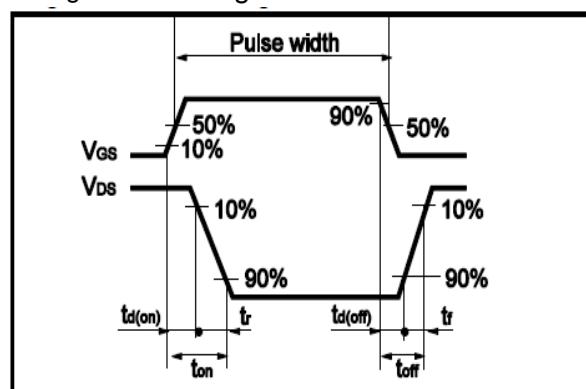


Fig.11 Avalanche Measurement Circuit

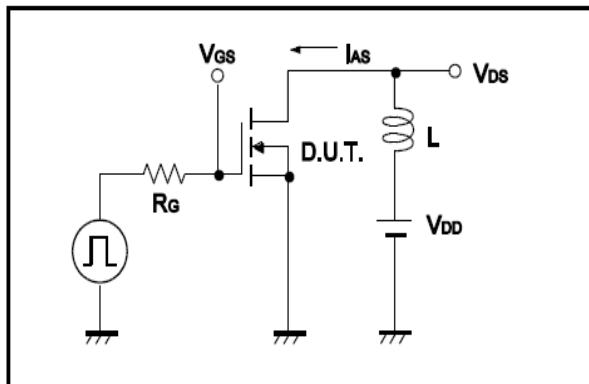
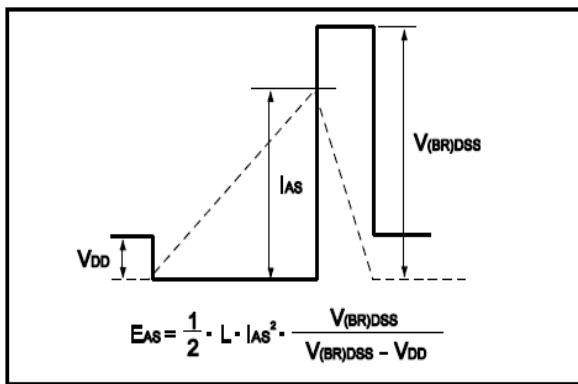


Fig.12 Avalanche Waveform





•Dimensions(SOT23-6)

Unit: mm

